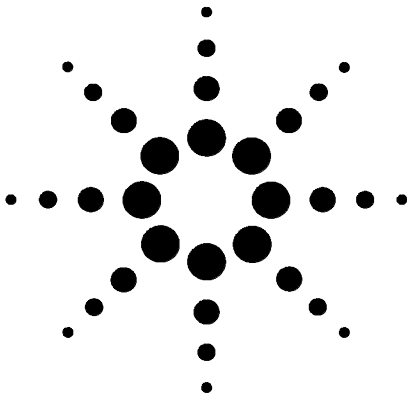


Agilent U2300A Series USB Modular Multifunction Data Acquisition (DAQ) Devices

Data Sheet



Features

- **Up to 3 MSa/s sampling rate for a single channel**
- **Functions as a standalone or modular unit**
- **Easy to use – plug-and-play and hot-swappable with Hi-Speed USB 2.0**
- **Up to 384 channels when incorporated into U2781A Agilent modular instrument chassis**
- **Easy-to-use bundled software for quick setup and data logging to PC**
- **12-bit or 16-bit A/D resolution**
- **24-bit programmable digital input/output**
- **Self-calibration capability**
- **Compatible with a wide range of Application Development Environments**
- **USBTCM 488.2 standards**

Introduction

Agilent U2300A Series USB modular multifunction data acquisition (DAQ) devices are a high performance PC data acquisition solution. The U2300A Series DAQ devices consist of two families: basic multifunction DAQ and high density multifunction DAQ. The basic multifunction DAQ family comes in four models while the high density multifunction DAQ family is made up of three models.

The U2300A Series DAQ devices applications extend across industrial and education environments. The DAQ device is well suited for R&D, manufacturing and design validation engineers, who require measurement devices with fast sampling rate.

High sampling rate

The U2300A Series DAQ devices have a sampling rate of up to 3 MSa/s for a single channel. When multiple channels are configured, it can sample data up to 1 MSa/s. This fast sampling capability allows users to perform intermittent detection easily. This also makes it ideal when dealing with high density analog input/output signals,

especially with different input ranges and sampling requirements.

Flexible standalone or modular capability

The U2300A Series DAQ devices are uniquely designed for the flexibility of functioning as a standalone or modular unit. When used with the U2781A modular instrument chassis, the number of channels can reach up to 384 channels.

Ease of use

The U2300A Series DAQ devices are equipped with Hi-Speed USB 2.0 interface for easy setup, and plug-and-play and hot swappable connectivity. Its ease-of-use makes it ideal for the education environment. Simplifying this further is the Agilent Measurement Manager software that offers a simple interface for quick setup, configuration and measurement control.

Flexible system and control

Polling and continuous mode - The U2300A Series DAQ devices provide two modes, the polling mode and the continuous mode. The continuous mode has the ability to acquire data continuously once the trigger signal is received.

Trigger sources - None (intermediate trigger), analog/external digital trigger, SSI/star trigger and master/slave trigger sources. All these trigger options give you the capability to configure trigger sources during A/D and D/A operations. Master/slave trigger and SSI/star trigger are recommended when USB modules are slotted into the Agilent U2781A USB modular instrument chassis.

Predefined function generator - Sine, square, triangle, sawtooth and noise waveforms.

Burst mode - This is incorporated to simulate simultaneous analog input.

Compatible with a range of Application Development Environments

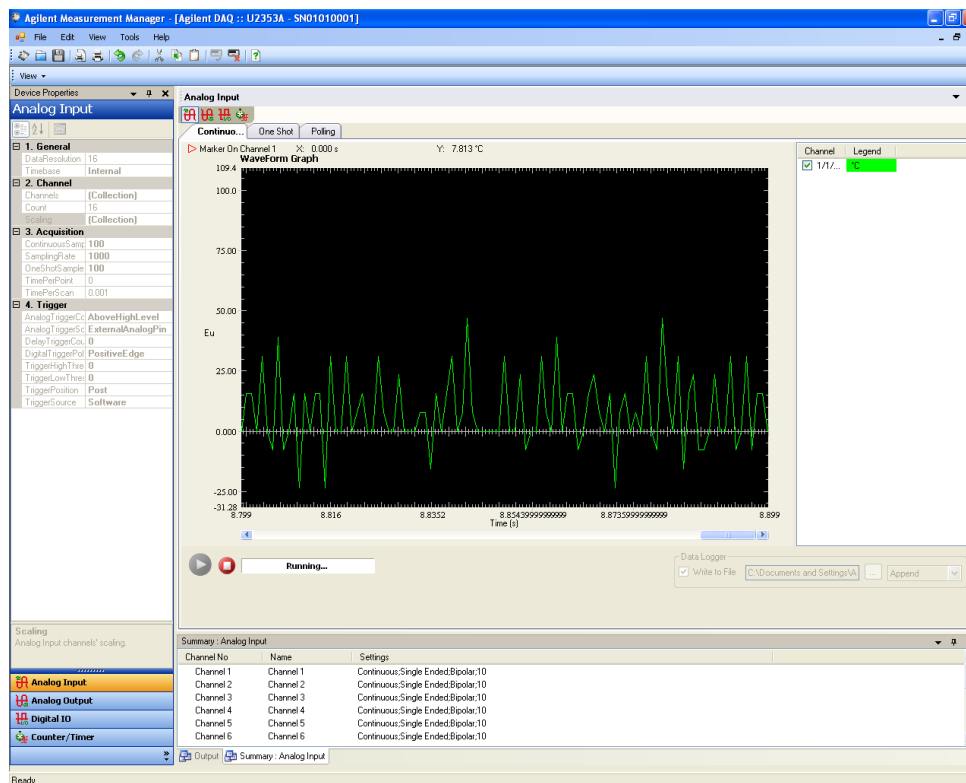
The Agilent U2300A DAQ devices are compatible with a wide range of Application Development Environments. This minimizes all the time taken by R&D and manufacturing engineers to use the devices in different software environments as they can program directly using SCPI commands.

Listed below are the popular development environments and tools that the DAQ device is compatible with:

- Agilent VEE and Agilent T&M Toolkit
- Microsoft Visual Studio.NET, C/C++ and Visual Basic 6
- LabVIEW
- MATLAB

For more information, please visit www.agilent.com/find/U2300A.

Figure 1 The Agilent Measurement Manager software user interface



ELECTRICAL SPECIFICATIONS

Basic Multifunction USB DAQ

| Model Number | U2351A | U2352A | U2353A | U2354A |
|---------------------------------------|--|--------|---|--------|
| Analog Input | | | | |
| Resolution | 16 bits, no missing codes | | | |
| Number of channels | 16 SE/8 DI (software selectable/ch) | | | |
| Maximum sampling rate | 250 kSa/s | | 500 kSa/s | |
| Scan list memory | Up to 100 selectable channel entries | | | |
| Programmable bipolar input range | $\pm 10\text{ V}$, $\pm 5\text{ V}$, $\pm 2.5\text{ V}$, $\pm 1.25\text{ V}$ | | | |
| Programmable unipolar input range | 0 to 10 V, 0 to 5 V, 0 to 2.5 V, 0 to 1.25 V | | | |
| Input coupling | DC | | | |
| Input impedance | 1 G Ω / 100 pF | | | |
| Operational common mode voltage range | $\pm 7.5\text{ V}$ maximum | | | |
| Overvoltage protection | Power on: Continuous $\pm 30\text{ V}$, Power off: Continuous $\pm 15\text{ V}$ | | | |
| Trigger sources | External analog/digital trigger, SSI/star trigger ⁽¹⁾ | | | |
| Trigger modes | Pre-trigger, delay-trigger, post-trigger and middle-trigger | | | |
| FIFO buffer size | Up to 8 MSa | | | |
| Analog Output | | | | |
| Resolution | 16 bits | N/A | 16 bits | N/A |
| Number of channels | 2 | N/A | 2 | N/A |
| Maximum update rate | 1 MSa/s | N/A | 1 MSa/s | N/A |
| Output ranges | 0 to 10 V, $\pm 10\text{ V}$, 0 to AO_EXT_REF, $\pm\text{AO_EXT_REF}$ ⁽²⁾ | N/A | 0 to 10 V, $\pm 10\text{ V}$, 0 to AO_EXT_REF, $\pm\text{AO_EXT_REF}$ ⁽²⁾ | N/A |
| Output coupling | DC | N/A | DC | |
| Output impedance | 0.1 Ω typical | N/A | 0.1 Ω typical | N/A |
| Stability | Any passive load up to 1500 pF | N/A | Any passive load up to 1500 pF | N/A |
| Power on state | 0 V steady state | N/A | 0 V steady state | N/A |
| Trigger sources | External analog/digital trigger, SSI/star trigger ⁽¹⁾ | N/A | External analog/digital trigger, SSI/star trigger ⁽¹⁾ | N/A |
| Trigger modes | Post-trigger and delay-trigger | N/A | Post-trigger and delay-trigger | N/A |
| FIFO buffer size | 1 channel: Maximum 8 MSa 2 channels: Maximum 4 MSa/ch | N/A | 1 channel: 8 MSa 2 channels: Maximum 4 MSa/ch | N/A |
| Function generation mode | Sine, square, triangle, sawtooth and noise waveforms | N/A | Sine, square, triangle, sawtooth and noise waveforms | N/A |
| Digital I/O | | | | |
| Number of channels | 24-bit programmable input/output | | | |
| Compatibility | TTL | | | |
| Input voltage | $V_{IL} = 0.7\text{ V max}$, $I_{IL} = 10\ \mu\text{A max}$ $V_{IH} = 2.0\text{ V min}$, $I_{IH} = 10\ \mu\text{A max}$ | | | |
| Input voltage range | -0.5 V to +5.5 V | | | |
| Output voltage | $V_{OL} = 0.45\text{ V max}$, $I_{OL} = 8\text{ mA max}$ $V_{OH} = 2.4\text{ V min}$, $I_{OH} = 400\ \mu\text{A max}$ | | | |

| General Purpose Digital Counter (GPC) | |
|--|---|
| Maximum count | $(2^{31}-1)$ bits |
| Number of channels | 2 independent up/down counter |
| Compatibility | TTL |
| Clock source | Internal or external |
| Base clock available | 48 MHz |
| Maximum clock source frequency | 12 MHz |
| Input frequency range | 0.1 Hz to 6 MHz at 50% duty cycle |
| Pulse width measurement range | 0.167 μ s to 178.956 s |
| Analog Trigger | |
| Trigger source | All analog input channels, External analog trigger (EXTA_TRIG) |
| Trigger level | \pm Full scale for internal; \pm 10 V for external |
| Trigger conditions | Above high, below low and window (software selectable) |
| Trigger level resolution | 8 bits |
| Bandwidth | 400 kHz |
| Input impedance for EXTA_TRIG | 20 k Ω |
| Coupling | DC |
| Overvoltage protection | Continuous for \pm 35 Vmaximum |
| Digital Trigger | |
| Compatibility | TTL/CMOS |
| Response | Rising or falling edge |
| Pulse width | 20 ns minimum |
| Calibration^[3] | |
| On board reference voltage | 5 V |
| Temperature drift | \pm 2 ppm/ $^{\circ}$ C |
| Stability | \pm 6 ppm/1000 hrs |
| General | |
| Remote interface | USB 2.0 High Speed |
| Device class | USBTMC class device |
| Programmable interface | Standard Commands for Programmable Instruments (SCPI) and IVI-COM |

[1] System Synchronous Interface (SSI) and star trigger commands are used when the modular device is incorporated into the chassis.

[2] Maximum external reference voltage for analog output channels (AO_EXT_REF) is \pm 10 V.

[3] 20 minutes warm-up time is recommended.

High Density Multifunction USB DAQ

| Model Number | U2355A | U2356A | U2331A |
|--|--|-----------|--|
| Analog Input | | | |
| Resolution | 16 bits, no missing codes | | 12 bits, no missing codes |
| Number of channels | 64 SE/32 DI (software selectable/ch) | | |
| Maximum sampling rate | 250 kSa/s | 500 kSa/s | 3 MSa/s (single channel) 1 MSa/s (multiple channels) |
| Scan list memory | Up to 100 selectable channel entries | | |
| Programmable bipolar input range | $\pm 10\text{ V}$, $\pm 5\text{ V}$, $\pm 2.5\text{ V}$, $\pm 1.25\text{ V}$ | | $\pm 10\text{ V}$, $\pm 5\text{ V}$, $\pm 2.5\text{ V}$, $\pm 1.25\text{ V}$, $\pm 1\text{ V}$, $\pm 0.5\text{ V}$, $\pm 0.25\text{ V}$, $\pm 0.2\text{ V}$, $\pm 0.05\text{ V}$ |
| Programmable unipolar input range | 0 to 10 V, 0 to 5 V, 0 to 2.5 V, 0 to 1.25 V | | 0 to 10 V, 0 to 5 V, 0 to 4 V, 0 to 2.5 V, 0 to 2 V, 0 to 1 V, 0 to 0.5 V, 0 to 0.4 V, 0 to 0.1V |
| Input coupling | DC | | |
| Input impedance | 1 G Ω / 100 pF | | |
| Operational common mode voltage range | $\pm 7.5\text{ V}$ maximum | | |
| Overvoltage protection | Power on: Continuous $\pm 30\text{ V}$; Power off: Continuous $\pm 15\text{ V}$ | | |
| Trigger sources | External analog/digital trigger, SSI/star trigger ⁽¹⁾ | | |
| Trigger modes | Pre-trigger, delay-trigger, post-trigger and middle-trigger | | |
| FIFO buffer size | Up to 8 MSa | | |
| Analog Output | | | |
| Resolution | 12 bits | | |
| Number of channels | 2 | | |
| Maximum update rate | 1 MSa/s | | |
| Output ranges | 0 to 10 V, $\pm 10\text{ V}$, 0 to AO_EXT_REF, \pm AO_EXT_REF ⁽²⁾ | | |
| Output coupling | DC | | |
| Output impedance | 0.1 Ω typical | | |
| Stability | Any passive load up to 1500 pF | | |
| Power on state | 0 V steady state | | |
| Trigger sources | External analog/digital trigger, SSI/star trigger ⁽¹⁾ | | |
| Trigger modes | Post-trigger and delay-trigger | | |
| FIFO buffer size | 1 channel: Maximum 8 MSa 2 channels: Maximum 4 MSa/ch | | |
| Function generation mode | Sine, square, triangle, sawtooth and noise waveforms | | |
| Digital I/O | | | |
| Number of channels | 24-bit programmable input/output | | |
| Compatibility | TTL | | |
| Input voltage | $V_{IL} = 0.7\text{ V}$ max, $I_{IL} = 10\ \mu\text{A}$ max $V_{IH} = 2.0\text{ V}$ min, $I_{IH} = 10\ \mu\text{A}$ max | | |
| Input voltage range | -0.5 V to +5.5 V | | |
| Output voltage | $V_{OL} = 0.45\text{ V}$ max, $I_{OL} = 8\text{ mA}$ max $V_{OH} = 2.4\text{ V}$ min, $I_{OH} = 400\ \mu\text{A}$ max | | |
| General Purpose Digital Counter (GPC) | | | |
| Maximum count | $(2^{31}-1)$ bits | | |
| Number of channels | 2 independent up/down counter | | |
| Compatibility | TTL | | |
| Clock source | Internal or external | | |
| Base clock available | 48 MHz | | |
| Maximum clock source frequency | 12 MHz | | |
| Input frequency range | 0.1 Hz to 6 MHz at 50% duty cycle | | |
| Pulse width measurement range | 0.167 μs to 178.956 s | | |

| Analog Trigger | |
|----------------------------------|--|
| Trigger source | All analog input channels, External analog trigger (EXTA_TRIG) |
| Trigger level | ±Full scale for internal; ±10 V for external |
| Trigger conditions | Above high, below low and window (software selectable) |
| Trigger level resolution | 8 bits |
| Bandwidth | 400 kHz |
| Input impedance for EXTA_TRIG | 20 kΩ |
| Coupling | DC |
| Overvoltage protection | Continuous for ±35 V maximum |
| Digital Trigger | |
| Compatibility | TTL/CMOS |
| Response | Rising or falling edge |
| Pulse width | 20 ns minimum |
| Calibration^[3] | |
| On board reference | 5 V |
| Temperature drift | ±2 ppm/°C |
| Stability | ±6 ppm/1000 hrs |
| General | |
| Remote interface | USB 2.0 High Speed |
| Device class | USBTMC class device |
| Programmable interface | Standard Commands for Programmable Instruments(SCPI) and IVI-COM |

[1] System Synchronous Interface (SSI) and star trigger commands are used when the modular device is incorporated into the chassis.

[2] Maximum external reference voltage for analog output channels (AO_EXT_REF) is ±10 V.

[3] 20 minutes warm-up time is recommended.

ELECTRICAL MEASUREMENT SPECIFICATIONS

Basic Multifunction USB DAQ

| Analog Input Measurement ⁽¹⁾ | | | | |
|--|---------------|---------------------------------|---------------|---------------------------------|
| Model Number | U2351A/U2352A | | U2353A/U2354A | |
| Function | 23 °C ± 5 °C | 0 °C to 18 °C 28 °C to 45 °C | 23 °C ± 5 °C | 0 °C to 18 °C 28 °C to 45 °C |
| Offset error | ±1 mV | ±5 mV | ±1 mV | ±5 mV |
| Gain error | ±2 mV | ±5 mV | ±2 mV | ±5 mV |
| –3 dB small signal bandwidth | 760 kHz | | 1.5 MHz | |
| 1% THD large signal bandwidth | 300 kHz | | 300 kHz | |
| System noise | 1 mVrms | 2 mVrms | 1 mVrms | 2.5 mVrms |
| CMRR | 62 dB | | 62 dB | |
| Spurious-free dynamic range (SFDR) | 88 dB | | 82 dB | |
| Signal-to-noise and distortion ratio (SINAD) | 80 dB | | 78 dB | |
| Total harmonic distortion (THD) | –90 dB | | –88 dB | |
| Signal-to-noise ratio (SNR) | 80 dB | | 78 dB | |
| Effective number of bits (ENOB) | 13 | | 12.6 | |

| Analog Output Measurement ⁽¹⁾ | | |
|--|--|---------------------------------|
| Model Number | U2351A/U2353A | |
| Function | 23 °C ± 5 °C | 0 °C to 18 °C 28 °C to 45 °C |
| Offset error | ±1 mV | ±4 mV |
| Gain error | ±4 mV | ±5 mV |
| Slew rate | 19 V/μs | |
| Rise time | 0.7 μs | 0.8 μs |
| Fall time | 0.7 μs | 0.8 μs |
| Settling time to 1% output error | 4 μs | |
| Driving capability | 5 mA | |
| Glitch energy | 5 ns-V (typical), 80 ns-V (maximum) | |

High Density Multifunction USB DAQ

| Analog Input Measurement ⁽¹⁾ | | | | | | |
|--|--------------|---------------------------------|--------------|---------------------------------|--------------|---------------------------------|
| Model Number | U2355A | | U2356A | | U2331A | |
| Function | 23 °C ± 5 °C | 0 °C to 18 °C 28 °C to 45 °C | 23 °C ± 5 °C | 0 °C to 18 °C 28 °C to 45 °C | 23 °C ± 5 °C | 0 °C to 18 °C 28 °C to 45 °C |
| Offset error | ±1 mV | ±2 mV | ±1 mV | ±2 mV | ±2 mV | ±3 mV |
| Gain error | ±2 mV | ±3 mV | ±2 mV | ±6 mV | ±6 mV | ±7.5 mV |
| –3 dB small signal bandwidth | 760 kHz | | 1.3 MHz | | 1.2 MHz | |
| 1% THD large signal bandwidth | 400 kHz | | 400 kHz | | N/A | |
| System noise | 1 mVrms | 2 mVrms | 1 mVrms | 4 mVrms | 3 mVrms | 5 mVrms |
| CMRR | 64 dB | | 61 dB | | 62 dB | |
| Spurious-free dynamic range (SFDR) | 88 dB | | 86 dB | | 71 dB | |
| Signal-to-noise and distortion ratio (SINAD) | 80 dB | | 78 dB | | 72 dB | |
| Total harmonic distortion (THD) | –90 dB | | –90 dB | | –76 dB | |
| Signal-to-noise ratio (SNR) | 80 dB | | 78 dB | | 72 dB | |
| Effective number of bits (ENOB) | 13 | | 12.6 | | 11.6 | |

| Analog Output Measurement ^[1] | | | | |
|--|--|---------------------------------|--|---------------------------------|
| Model Number | U2355A/U2356A | | U2331A | |
| Function | 23 °C ± 5 °C | 0 °C to 18 °C 28 °C to 45 °C | 23 °C ± 5 °C | 0 °C to 18 °C 28 °C to 45 °C |
| Offset error | ±1 mV | ±4 mV | ±1.5 mV | ±3 mV |
| Gain error | ±4 mV | ±5 mV | ±4 mV | ±5 mV |
| Slew rate | 19 V/μs | | 19 V/μs | |
| Rise time | 0.7 μs | 0.8 μs | 0.7 μs | 0.8 μs |
| Fall time | 0.7 μs | 0.8 μs | 0.7 μs | 0.8 μs |
| Settling time to 1% output error | 4 μs | | 4 μs | |
| Driving capability | 5 mA | | 5 mA | |
| Glitch energy | 5 ns-V (typical), 80 ns-V (maximum) | | 5 ns-V (typical), 80 ns-V (maximum) | |

[1] Specifications are for 20 minutes of warm-up time, calibration temperature at 23 °C and input range of ±10 V.

TEST CONDITIONS

| Dynamic Range Test | Model Number | Test Conditions ^[2] |
|-----------------------------|---|---|
| SFDR, THD, SINAD, SNR, ENOB | U2351A | Sampling rate: 250 kSa/s |
| | U2352A | Fundamental frequency: 2.4109 kHz |
| | U2355A | Number of points: 8192 |
| | | Fundamental input voltage: FSR –1 dB FS |
| | U2353A | Sampling rate: 500 kSa/s |
| | U2354A | Fundamental frequency: 4.974 kHz |
| | U2356A | Number of points: 16384 |
| | | Fundamental input voltage: FSR –1 dB FS |
| | U2331A | Sampling rate: 3 MSa/s |
| | Fundamental frequency: 29.892 kHz | |
| | Number of points: 65536 | |
| | Fundamental input voltage: FSR –1 dB FS | |

| Dynamic Range Test | Model Number | Test Conditions ^[2] |
|---|--------------|--|
| <ul style="list-style-type: none"> –3 dB small signal bandwidth 1% THD large signal bandwidth | U2351A | Sampling rate: 250 kSa/s |
| | U2352A | Input voltage: |
| | U2355A | <ul style="list-style-type: none"> –3dB small signal bandwidth 10% FSR 1% THD large signal bandwidth FSR –1 dB FS |
| | U2353A | Sampling rate: 500 kSa/s |
| | U2354A | Input voltage: |
| | U2356A | <ul style="list-style-type: none"> –3 dB small signal bandwidth 10% FSR 1% THD large signal bandwidth FSR –1 dB FS |
| | U2331A | Sampling rate: 3 MSa/s |
| | | Input voltage: |
| | | <ul style="list-style-type: none"> –3 dB small signal bandwidth 10% FSR 1% THD large signal bandwidth FSR –1 dB FS |

[2] DUT setting at ±10 V bipolar.

GENERAL SPECIFICATIONS

REMOTE INTERFACE

- USB 2.0 High Speed
- USBTMC class device

POWER CONSUMPTION

- +12 VDC, 550 mA maximum

OPERATING ENVIRONMENT

- Operating temperature from 0 °C to +55 °C
- Relative humidity at 15% to 85% RH (non-condensing)
- Altitude up to 4600 meters

STORAGE COMPLIANCE

- 20 °C to +70 °C

SAFETY COMPLIANCE

Certified with:

- IEC 61010-1:2001/EN 61010-1:2001 (2nd Edition)
- USA: UL61010-1: 2004
- Canada: CSA C22.2 No.61010-1:2004

EMC COMPLIANCE

Certified with:

- IEC/EN 61326-1 1998
- CISPR 11: 1990/EN55011:1991, Group 1, Class A
- CANADA: ICES-001: 1998
- Australia/New Zealand: AS/NZS 2064.1

SHOCK and VIBRATION

- Tested to IEC/EN 60068-2

IO CONNECTOR

- 68-pin female VHDCI Type

DIMENSION (WxDxH)

- 120 mm x 182.40 mm x 44 mm (with plastic casing)
- 105 mm x 174.54 mm x 25 mm (without plastic casing)

WEIGHT

- 565 g (with plastic casing)
- 400 g (without plastic casing)

WARRANTY

- One year

SOFTWARE REQUIREMENTS

Agilent connectivity software included

Agilent IO Libraries Suite 14.2

Minimum system requirements (IO libraries and drivers)

| | |
|------------------|---|
| PC hardware | 500 MHz Pentium III or higher, 256 MB RAM, |
| Operating system | 40 GB hard disk space, CD-ROM drive Windows 2000 and above |

Computer interface

High Speed USB 2.0

Software driver support for programming languages

Software driver : IVI-COM

Compatible with programming environments:

Agilent VEE, Agilent T&M Toolkit
Microsoft Visual Studio.NET, C/C++
Visual Basic 6
LabVIEW
MATLAB

PRODUCT OVERVIEW

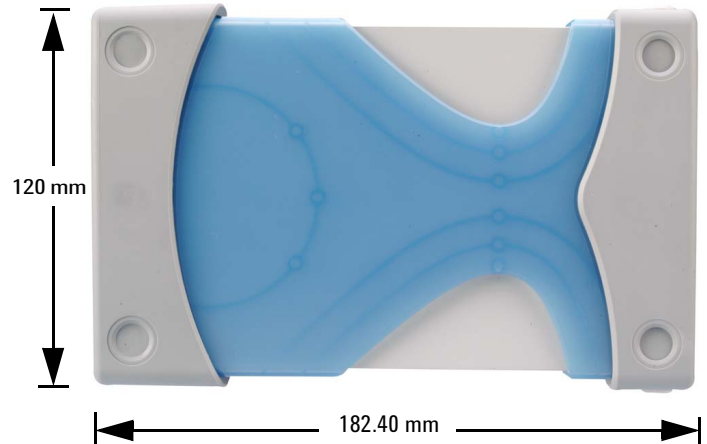
FRONT VIEW



REAR VIEW



TOP VIEW



Standard Shipped Components:

- USB interface cable
- L-Mount Kit (used with modular instrument chassis)
- Quick Start Guide
- Certificate of Calibration (CoC)
- Product Reference CD-ROM
- Agilent IO Libraries Suite 14.2 CD-ROM

Optional Accessories:

- U2901A - Terminal Board and SCSI-II 68 pin connector with 1-meter cable
- U2902A - Terminal Board and SCSI-II 68 pin connector with 2-meter cable
- U2781A 6-slot USB modular instrument chassis

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